



US00D851519S

(12) **United States Design Patent**  
**Barton et al.**

(10) **Patent No.:** **US D851,519 S**

(45) **Date of Patent:** **\*\* Jun. 18, 2019**

(54) **DIAGNOSTIC ANALYZER**

(56) **References Cited**

(71) Applicant: **Abbott Laboratories**, Abbott Park, IL (US)

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(73) Assignee: **Abbott Laboratories**, Abbott Park, IL (US)

*Primary Examiner* — Antoine Duval Davis

(\*\*) Term: **15 Years**

(74) *Attorney, Agent, or Firm* — Hanley, Flight & Zimmerman, LLC

(21) Appl. No.: **29/633,975**

(22) Filed: **Jan. 17, 2018**

(57) **CLAIM**

The ornamental design for a "diagnostic analyzer", as shown and described.

**Related U.S. Application Data**

(63) Continuation of application No. 29/587,977, filed on Dec. 16, 2016, now Pat. No. Des. 811,251, which is (Continued)

**DESCRIPTION**

(51) **LOC (11) Cl.** ..... **10-04**

(52) **U.S. Cl.**

USPC ..... **D10/81; D24/216**

(58) **Field of Classification Search**

USPC ..... D10/81; D24/216, 219, 220, 232, 233, D24/234

CPC .. G01N 21/00; G01N 21/01; G01N 2201/022; G01N 2201/0221; G01N 2201/0222; G01N 2201/0224; G01N 2201/0225; G01N 2201/0227; G01N 2201/0228; G01N 2201/024; G01N 2201/0245; G01N 2021/0112–21/958; G01N 2021/0106–2021/9586; G01N

(Continued)

FIG. 1 is a front left perspective view of a diagnostic analyzer.

FIG. 2 is a front view of the analyzer of FIG. 1.

FIG. 3 is a rear view of the analyzer of FIG. 1.

FIG. 4 is a right side view of the analyzer of FIG. 1.

FIG. 5 is a left side view of the analyzer of FIG. 1.

FIG. 6 is a top view of the analyzer of FIG. 1.

FIG. 7 is a bottom view of the analyzer of FIG. 1.

FIG. 8 is a front left perspective view of a diagnostic analyzer.

FIG. 9 is a front view of the analyzer of FIG. 8.

FIG. 10 is a rear view of the analyzer of FIG. 8.

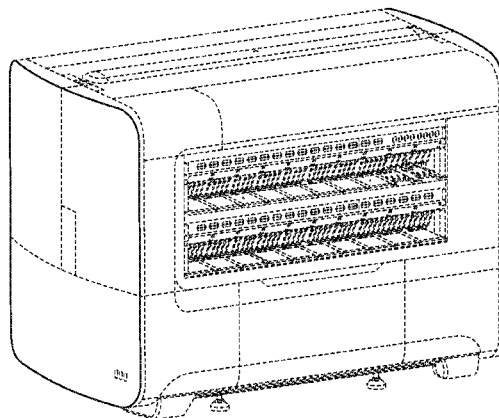
FIG. 11 is a right side view of the analyzer of FIG. 8.

FIG. 12 is a left side view of the analyzer of FIG. 8.

FIG. 13 is a top view of the analyzer of FIG. 8; and,

FIG. 14 is a bottom view of the analyzer of FIG. 8.

(Continued)



The features shown in broken lines form no part of the claimed design.

**1 Claim, 8 Drawing Sheets**

**Related U.S. Application Data**

a continuation of application No. 29/531,576, filed on Jun. 26, 2015, now Pat. No. Des. 777,048.

(58) **Field of Classification Search**

CPC ..... 35/00–35/1097; G01N  
2035/00019–2035/1093; G01N  
2204/022–2204/0228

See application file for complete search history.

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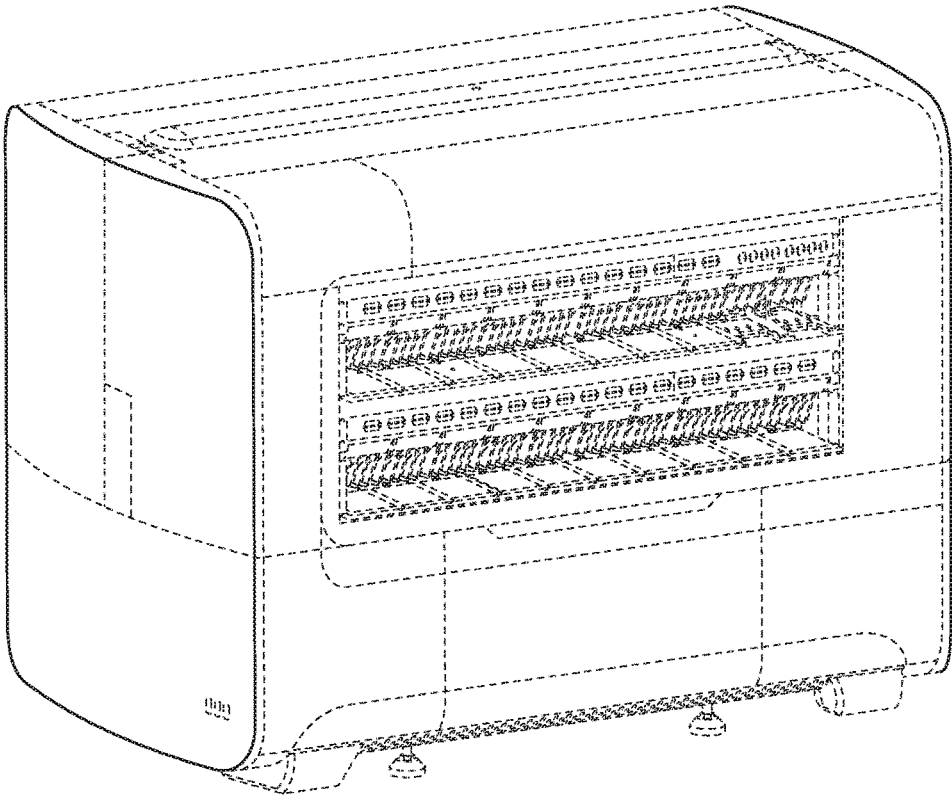


FIG. 1

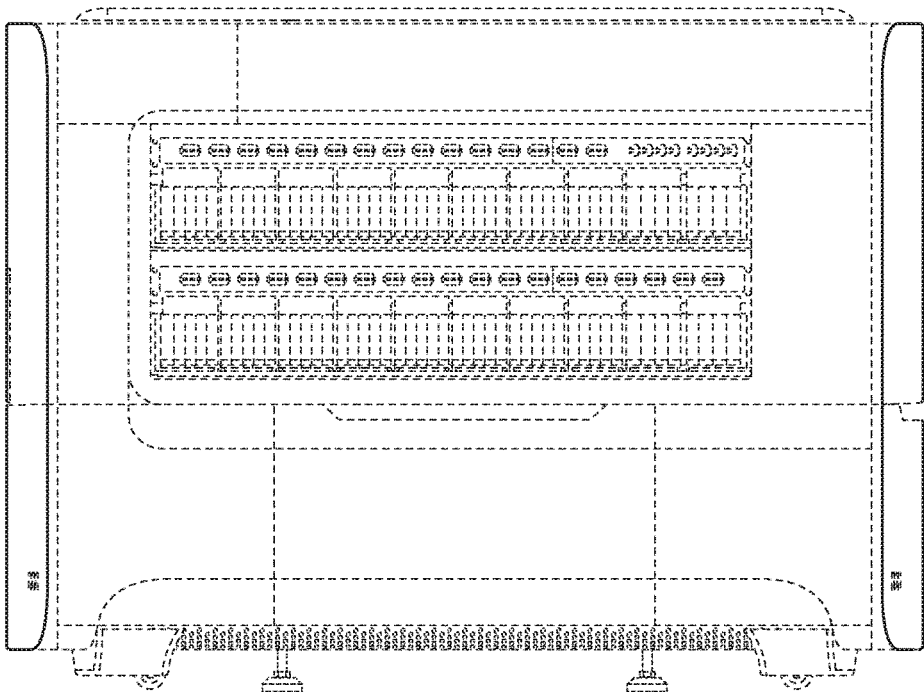


FIG. 2

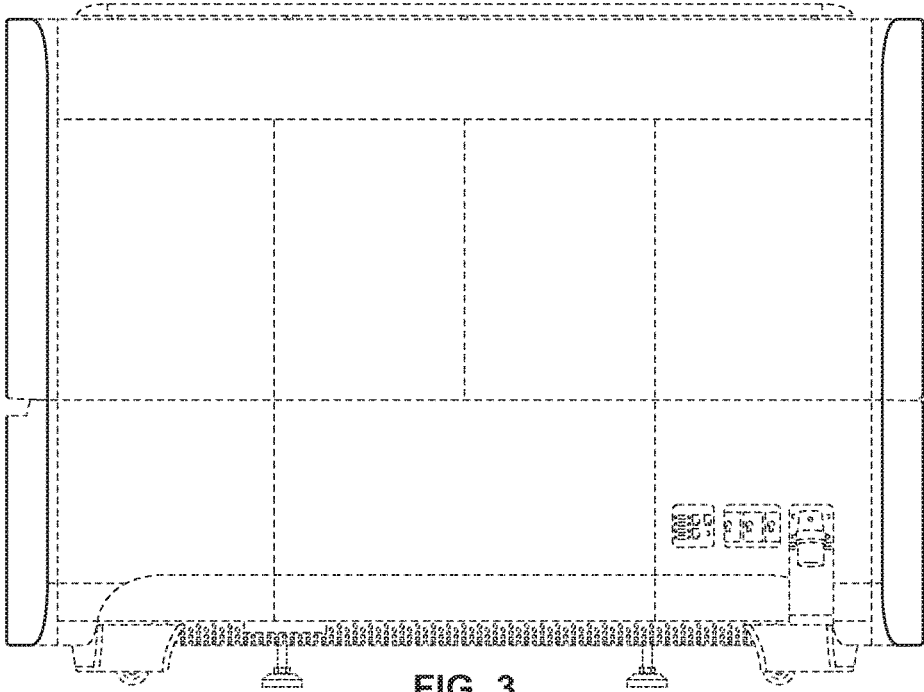


FIG. 3

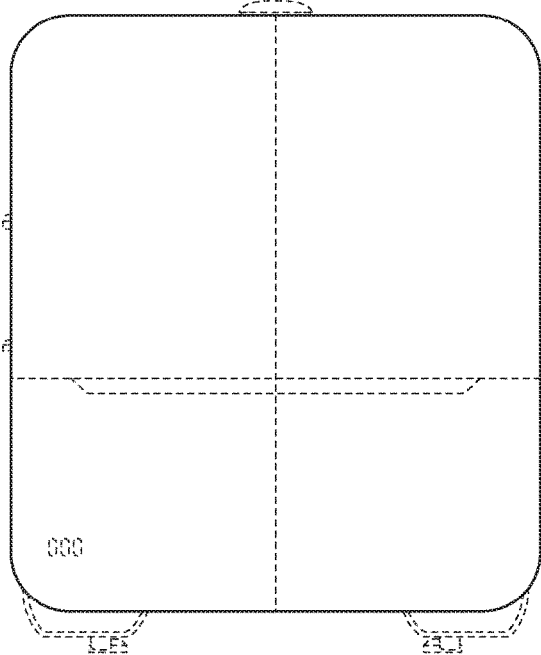


FIG. 4

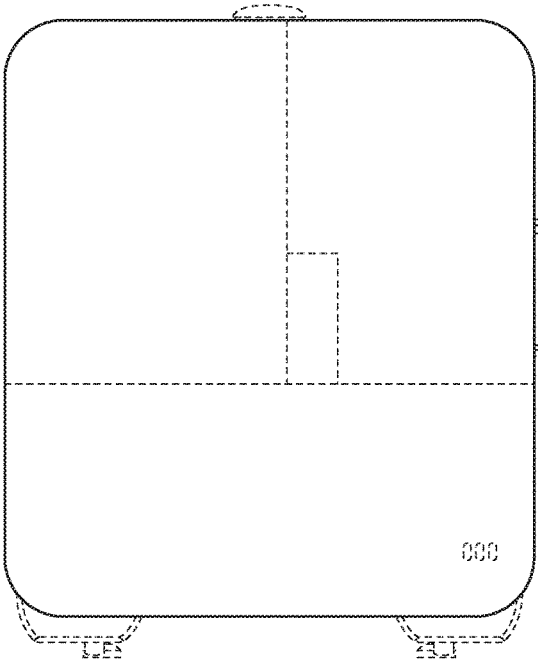


FIG. 5

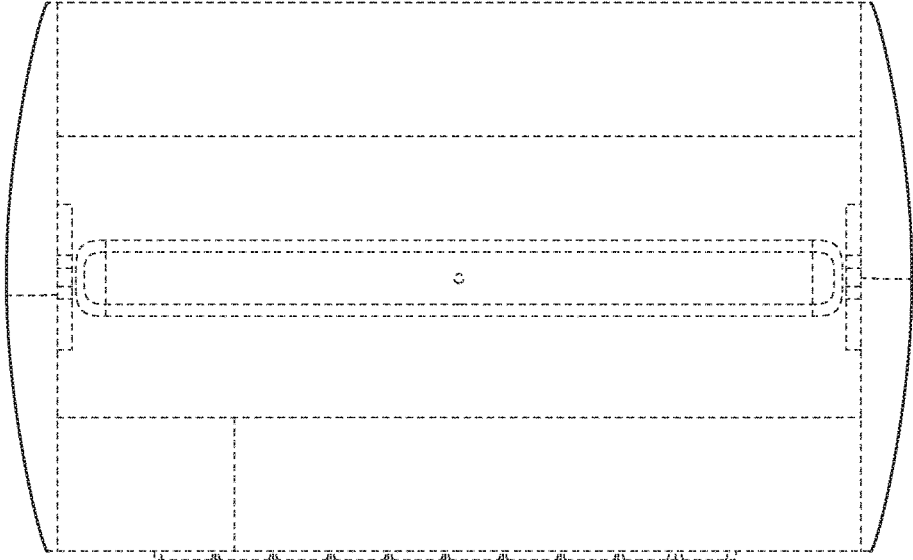


FIG. 6

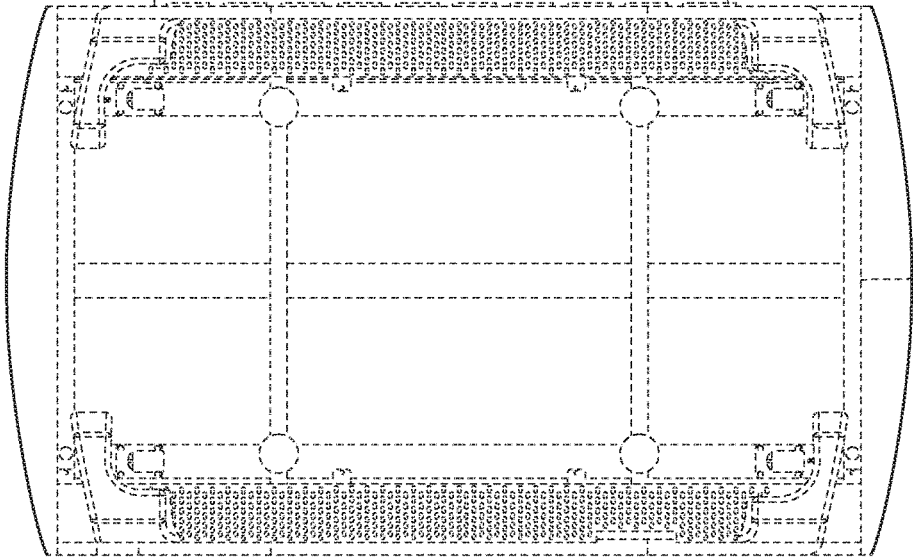


FIG. 7

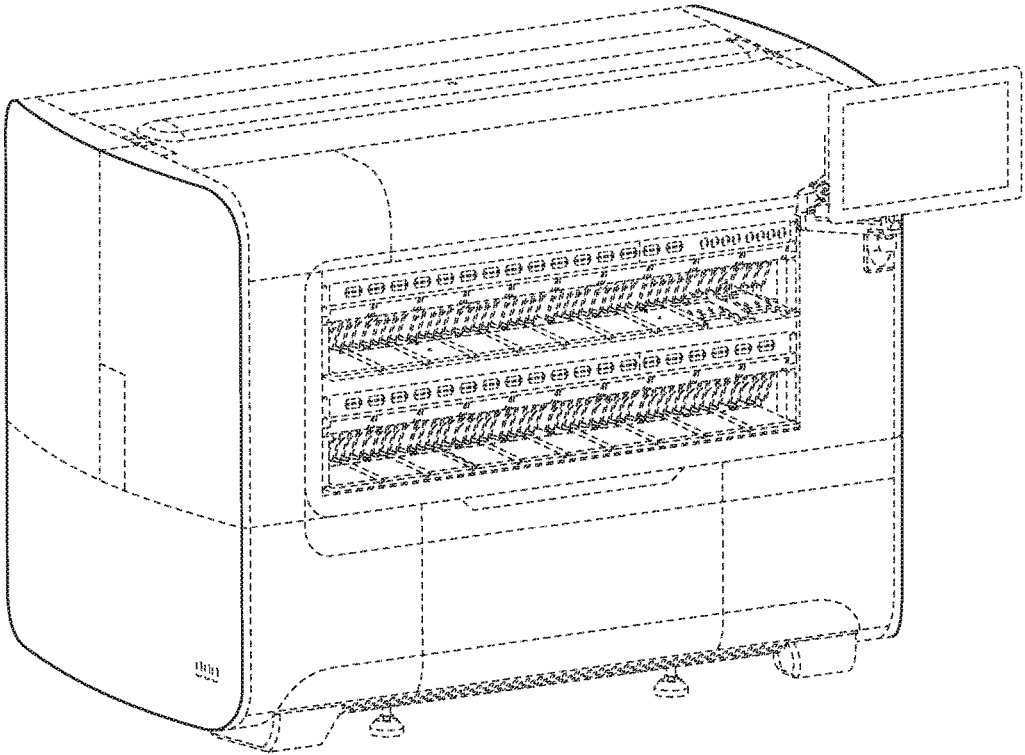


FIG. 8

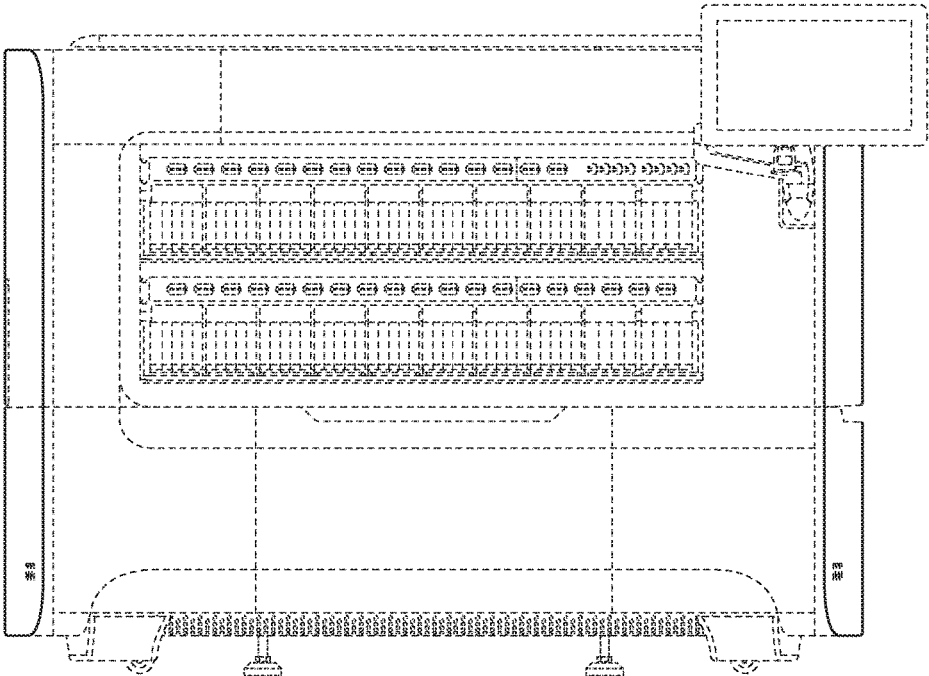


FIG. 9

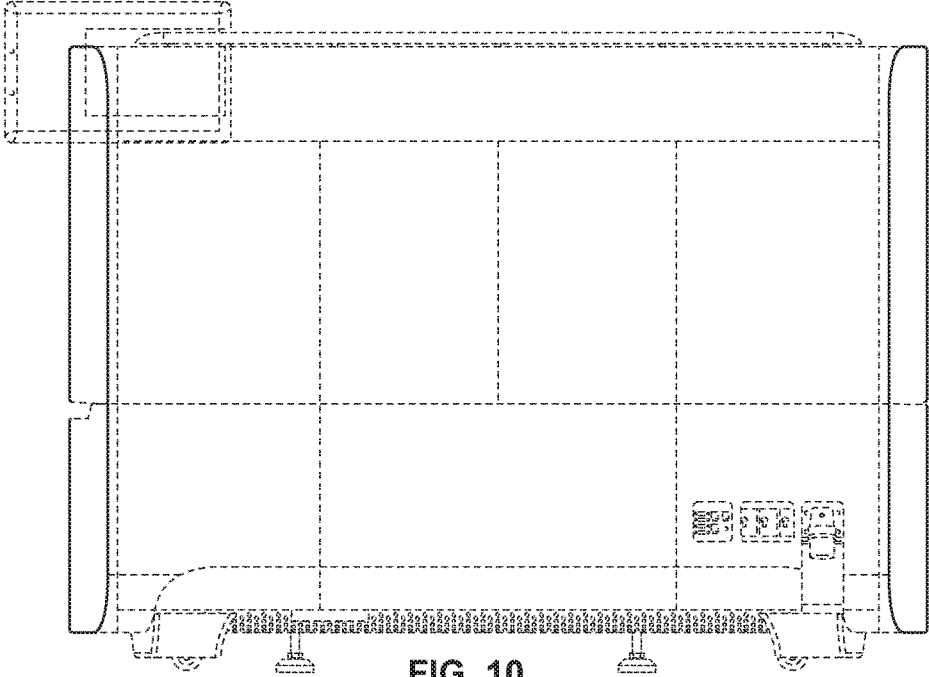


FIG. 10



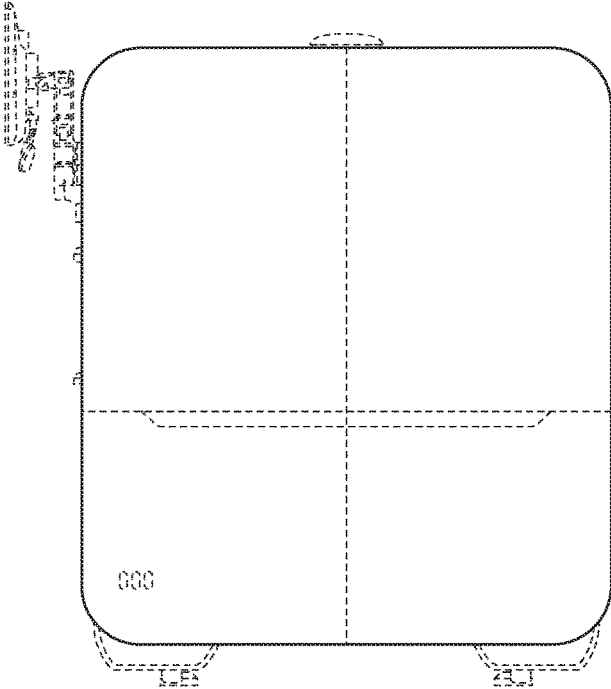


FIG. 11

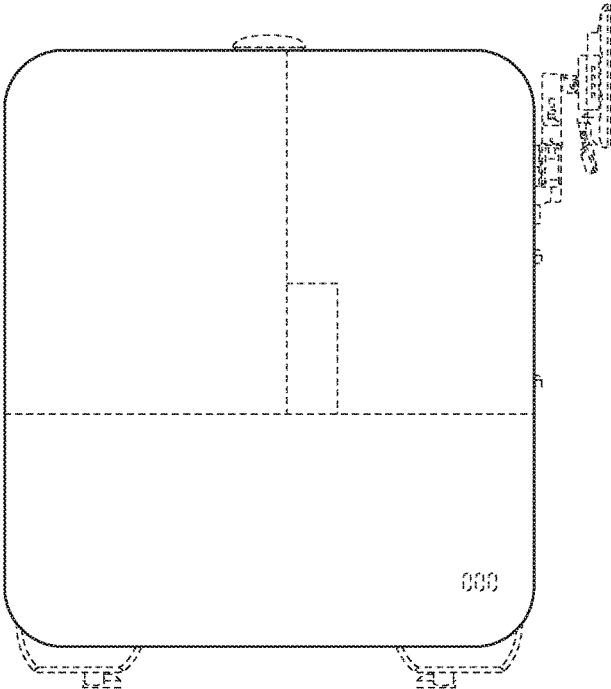


FIG. 12

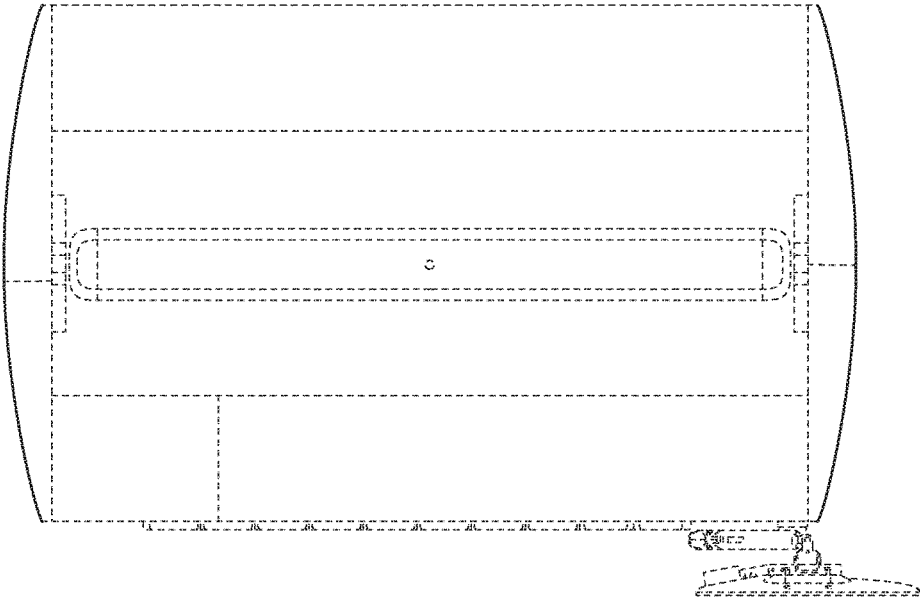


FIG. 13

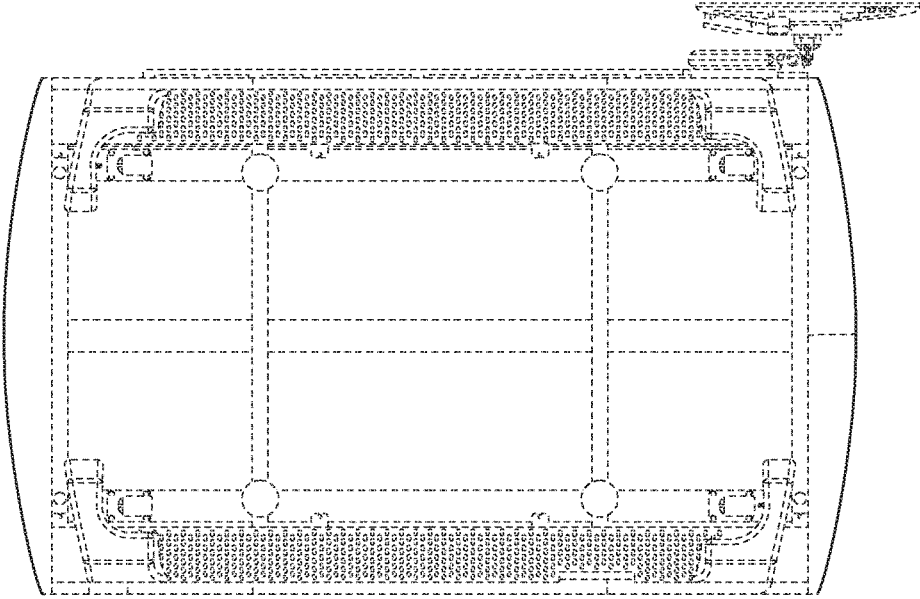


FIG. 14